

Issue Classification				Application/Control No.			Applicant(s)/Patent under Reexamination		
				09/898,295			HOOBLER, RYAN		
				Examiner			Art Unit		
				Eva Yi Zheng			2611		

ORIGINAL				CROSS REFERENCE(S)						
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
375		222		375	251	216	377			
INTERNATIONAL CLASSIFICATION				370	294					
H	0	4	B	1/38	455	402	557			
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Eva Zheng 7/14/06 (Assistant Examiner) (Date)				Chieh M. Fan CHIEH M. FAN SUPERVISORY PATENT EXAMINER (Primary Examiner) (Date) 7/17/06					Total Claims Allowed: 4	
									O.G. Print Claim(s) 13	O.G. Print Fig. 1

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
	1		31		61		91
	2		32		62		92
	3		33		63		93
	4		34		64		94
	5		35		65		95
	6		36		66		96
	7		37		67		97
	8		38		68		98
	9		39		69		99
	10		40		70		100
	11		41		71		101
	12		42		72		102
1	13		43		73		103
2	14		44		74		104
3	15		45		75		105
4	16		46		76		106
	17		47		77		107
	18		48		78		108
	19		49		79		109
	20		50		80		110
	21		51		81		111
	22		52		82		112
	23		53		83		113
	24		54		84		114
	25		55		85		115
	26		56		86		116
	27		57		87		117
	28		58		88		118
	29		59		89		119
	30		60		90		120